

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







SHARP S21ME Series

S21ME Series

European Safety Standard Approved, Long Creepage Distance Type Phototriac Couplers

- * Lead forming type (I type) of S21ME series is also available. (S21ME3I/S21ME4I/S21ME3FI/S21ME4FI)
- * Taping reel type (P type) of S21ME series is also available. (S21ME3P/S21ME4P/S21ME3FP/S21ME4FP)
- * DIN-VDE0884 approved type is also available as an option.

■ Features

1. Long creepage distance type

(Creepage distance: 8mm or more)

2. Internal insulation distance: 0.5mm or more

3. Description of approved safety standards

(Lead forming type is also registered as

S21ME3/S21ME4.)

Recoginized by UL 1577 (double protection included)

file No. E64380

Approved by VDE, No. 68328

Approved by BSI (BS415: No. 6690, BS7002: No. 7421)

Approved by SEMKO

S21ME3/ S21ME3F No. 8705122

S21ME4/S21ME4F No. 8705123

Approved by DEMKO, No. 84857

Approved by EI

S21ME3/ S21ME3F No. 099443-01

S21ME4/S21ME4F No. 099444-01

4. Low minimum trigger current

 $(I_{FT}: MAX.7mA)$

5. Built-in zero-cross circuit

(S21ME4/S21ME4F)

6. Lead forming type/ **S21ME3F**, **S21ME4F**

(Distance between lead pins: 10.16mm)

7. High repetitive peak OFF-state voltage

 $(V_{DRM}: MIN. 600V)$

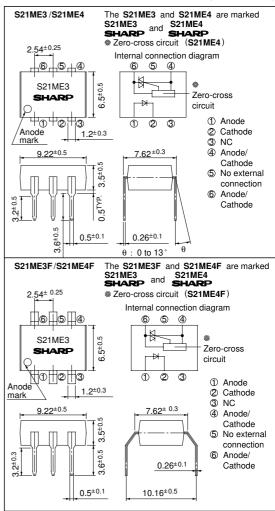
8. High isolation voltage between input and output

 $(V_{iso}: 5000V_{rms})$

■ Applications

1. For triggering medium/high power triac

■ Outline Dimensions (Unit: mm)



■ Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

	Parameter	Symbol	Rating	Unit	
Input	Forward current	I_F	50	mA	
	Reverse voltage	V _R	6	V	
Output	RMS ON-state current	I_T	100	mA _{rms}	
	*1Peak one cycle surge current	I surge	1.2	A	
	Repetitive peak OFF-state voltage	V_{DRM}	600	V	
	*2Isolation voltage	Viso	5 000	V _{rms}	
Operating temperature		T opr	- 30 to + 100	°C	
	Storage temperature	T stg	T _{stg} - 55 to + 125		
	*3Soldering temperature	T sol	260	°C	

^{*1 50}Hz, sine wave

■ Electro-optical Characteristics

 $(Ta = 25^{\circ}C)$

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Innut	Forward voltage		V_F	$I_F = 20mA$	-	1.2	1.4	V
Input	Reverse current		I_R	$V_R = 3V$	-	-	10-5	A
	Repetitive peak OFF-state current		I_{DRM}	$V_{DRM} = Rated$	-	-	10-6	A
Output	ON-state voltage		V _T	$I_T = 100 \text{mA}$	-	1.7	3.0	V
	Holding current		I_{H}	$V_D = 6V$	0.05	-	3.5	mA
	Critical rate of rise	S21ME3 S21ME3F	dV/dt	$V_{DRM} = 1/\sqrt{2} \cdot Rated$	500	-	-	V/μs
	of OFF-state voltage	S21ME4 S21ME4F			100	-	-	
	Zero-cross voltage	S21ME4 S21ME4F	Vox	Resistance load, I _F = 15mA	-	-	35	V
	Minimum trigger current		IFT	$V_D = 6V, R_L = 100\Omega$	-	-	7.0	mA
Transfer charac- teristics	Isolation resistance		R _{ISO}	DC500V, 40 to 60% RH	5 x 10 ¹⁰	1011	-	Ω
	Turn-on time S21ME3 S21ME3F S21ME4F S21ME4F	S21ME3 S21ME3F		$V_D = 6V$, $R_L = 100\Omega$, $I_F = 20mA$	-	40	100	μs
		t _{on}	f = 50Hz	-	-	1/2	cycle	
	Turn-off time	S21ME4 S21ME4F	t off	f = 50Hz	-	-	1/2	cycle

^{*2 40} to 60% RH, AC for 1 minute f = 60Hz

^{*3} For 10 seconds

Fig. 1 RMS ON-state Current vs.
Ambient Temperature

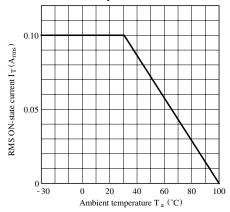


Fig. 3 Forward Current vs. Forward Voltage

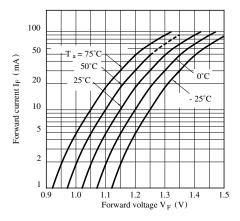


Fig. 5 Relative Repetitive Peak OFF-state Voltage vs. Ambient Temperature

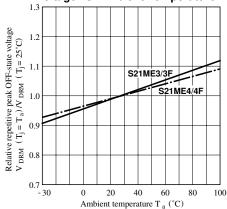


Fig. 2 Forward Current vs.
Ambient Temperature

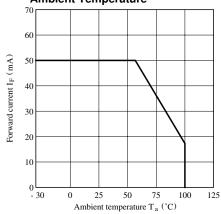


Fig. 4 Minimum Trigger Current vs.

Ambient Temperature

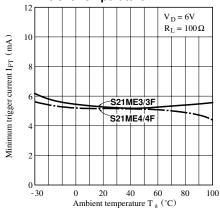


Fig. 6 ON-state Voltage vs.

Ambient Temperature

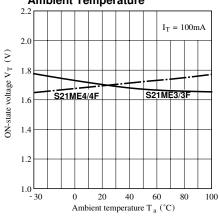


Fig. 7 Holding Current vs.

Ambient Temperature

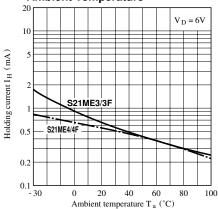


Fig. 8-b Repetitive Peak OFF-state Current vs. OFF-state Voltage

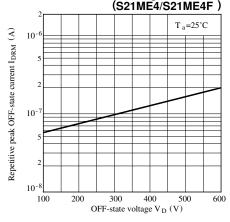


Fig. 9-b Repetitive Peak OFF-state Current vs. Ambient Temperature

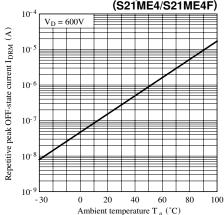


Fig. 8-a Repetitive Peak OFF-state Current vs. OFF-state Voltage (S21ME3/S21ME3F)

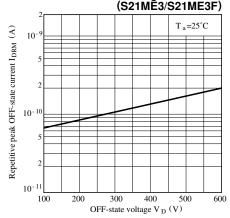


Fig. 9-a Repetitive Peak OFF-state Current vs. Ambient Temperature

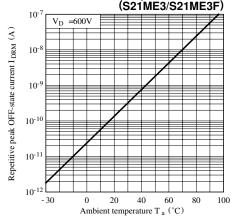


Fig.10 Turn-on Time vs. Forward Current (S21ME3/S21ME3F)

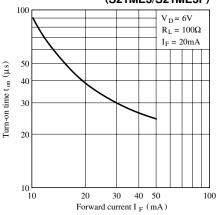
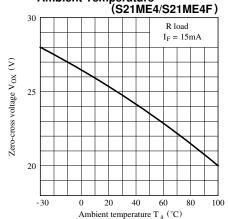
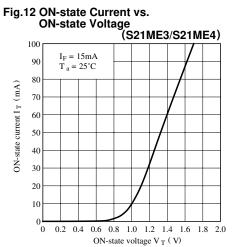


Fig.11 Zero-cross Voltage vs. Ambient Temperature





• Please refer to the chapter "Precautions for Use" (Page 78 to 93).

NOTICE

- •The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.
- •Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.
- Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:
 - (i) The devices in this publication are designed for use in general electronic equipment designs such as:
 - Personal computers
 - Office automation equipment
- Telecommunication equipment [terminal]
- Test and measurement equipment
- Industrial control
- Audio visual equipment
- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:
- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- Traffic signals
- Gas leakage sensor breakers
- Alarm equipment
- Various safety devices, etc.
- (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
- Space applications
- Telecommunication equipment [trunk lines]
- Nuclear power control equipment
- Medical and other life support equipment (e.g., scuba).
- •Contact a SHARP representative in advance when intending to use SHARP devices for any "specific" applications other than those recommended by SHARP or when it is unclear which category mentioned above controls the intended use.
- •If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Control Law of Japan, it is necessary to obtain approval to export such SHARP devices.
- •This publication is the proprietary product of SHARP and is copyrighted, with all rights reserved. Under the copyright laws, no part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, for any purpose, in whole or in part, without the express written permission of SHARP. Express written permission is also required before any use of this publication may be made by a third party.
- Contact and consult with a SHARP representative if there are any questions about the contents of this
 publication.